Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/088,706	NAYAR ET AL.	
Examiner	Art Unit	
LUONG T. NGUYEN	2622	

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Class	Subclass	Date	Examiner
348	37	7/9/2006	LN
348	344	7/9/2006	LN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES LUDING SEARCH STRATEGY)	
DATE EXMF	
99,143,335,344,345 y, see search history 7/9/2006 LN	348/36,37,207.99,143,335,344,345 (text search only, see search history printout)
T; IBM_TDB) see   7/9/2006   LN	EAST (US_PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) see search history printout